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45- PV121- An ANFIS-based modeling for a Photovoltaic Power Supply (PVPS) system

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49-PV122- Application of neural networks and genetic algorithms for

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The high Energy Region of the Absorption Edge of a-Si:H, An analytic study

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Abstract

In this work, the authors used the experimental results due to Jackson et al for the density of states convolution integral (J(E)) vs. photon energy E for GD a-Si:H films in the energy range (1.6-3.7)eV. We plotted the square and the cubic roots of J(E) as a function of E, the square root plot $I^{1/2}$ (E) exhibited a fairly linear behaviour in the energy range (~1.8-3.3)eV. Because J(E) depends only on the density of states distributions near the band edges of the valence and conduction bands, in contrast to the imaginary part of the dielectric function $\in_2(E)$ which depends also on the transition matrix element, we concluded that the density of states distribution near each band edge could be approximated by a parabolic law behaviour i.e. $N(E)\alpha E^{1/2}$. As Jackson et all found the electric dipole matrix element squared $R^2(E)$ is constant in the energy range of for GD a-Si:H films, we conclude that the theoretical model due to Cody $(N(E)\alpha E^{1/2}, R^2(E))$ = constant) is in accord the above experimental findings.

Thus we recommend the plot due to Cody $(\in_2^{1/2} vs.E)$ as the most suitable plot to analyze \in_2 - data of the high absorption region of the optical absorption edge of high quality GD a-Si:H films, and Cody's theoretical model as the proper entry towards a possible future solution of the optical gap problem in this material at least.

Introduction

It is well known, that the magnitude of the forbidden gap and its relation to the optical absorption edge is still a mystery in amorphous semiconductors [1]. Fundamentally, this is because that the optical absorption depends not on a convolution of the conduction band (CB) and valence band (VB) density of states but also on the transition matrix element [2].

In order to possible solve this dilemma, two independent measurements of the density of states distributions close to both edges of the valence and conduction bands, and the optical absorption spectrum of the high photon energy region $(\alpha \geq 10^4 \, cm^{-1})$ where α is the absorption coefficient of the absorption edge on the same samples or at least prepared at the same run, should be performed.

Because of the difficulties in achieving such kind of a project, it is seldom found in literature, except may be is the very important and it might be considered unique work of Jackson et al [2] about 20 years ago, where they determined the energy dependence of

the optical matrix element of GD- a-Si:H films using independent measurements results of the density of states and the \in_2 spectra. (where \in_2 is the imaginary part of the dielectric function) in the energy range (~0.6-6eV).

We think that the correct implications of this important and fairly accurate work are not well established in the scientific society, except for an important note stated by Cody some years ago [3].

For this purpose, and on behalf of Jackson et al important work, the authors here studied it in more details, to make use of its full implications, in the hope of catching the right thread towards a possible solution of the optical gap problem in the near future at least for high quality GD a-Si:H films which are now very important optoelectronic materials.

Theory

Following Jackson et al [2] , the imaginary part of the dielectric function an amorphous structure and unpolarized light is given by:

$$\in_2 (E) = \frac{(2\pi e)^2}{3\rho A} R^2(E) \int N_F(E' + E) dE' - - - - - - - - (1)$$

Where E is the photon energy , E' is the state energy , e is the electron charge , $N_v(E')[N_c(E')]$ is the valence (conduction) band density of states , ρ_A is the atomic density , and $R^2(E)$ is the square of the normalized (with respect of the crystal) average dipole matrix element .

If for simplicity, we assume that the density of states distribution near the mobility edge of the valence (conduction) band is a simple power law $(N(E')\alpha E'^m)$ i.e symmetrical DOS (an assumption which is usually not easy to justify in amorphous materials) we can define a theoretical optical energy gap E_o as seen in the following resulting expression [1]

$$E^q \in (E) = K_+(E - E_+)' - - - - - - (2)$$

Where : K_{th} is a theoretical prefactor , q is an index indicating the simple power dependence of the dipole matrix element (if possible) $(R^2\alpha E^{-q})$, (r=2m+1) and E_0 exactly defined if the limits of the density of states convolution integral in eq.1 is equal to the zeros of the two functions inside it [4].

Because the dependence of ϵ_2 (E) on both the values of q and r, there is no unique way to define the exact value of the optical gap E_0 only if an independent measurement of the density of states near the mobility edge is accomplished for the sample under study which is a very hard task. According to our knowledge, only Jackson et al [2] succeeded in doing for GD a-Si:H samples, the energy dependence of $R^2(E)$ in the energy range (~0.6-5.9)eVwas determined from combined measurements of the optical absorption and

the density of states distribution in the appropriate energy range for GD a-Si:H samples prepared by the above authors .

They found that the dipole matrix element, $R^2(E)$, the constant within the errors of their experiment for energy up to 3.4eV and decreases roughly as E^{-5} above this energy,

This is in partial accordance with the assumption of Cody [1] that the dipole matrix element is constant (to $\sim 20 \text{eV}$) and not the momentum matrix element $P^2(E)$ as proposed previously by Tauc [5].

In accord with to equation (2) ,with q=0 as the above mentioned experimental results indicated, Cody [1] found that this data of $\epsilon_2^{-1/2}$ for a-SiH_X (x=0.09) as a function of E fits excellently to the linear equation [$\epsilon_2^{-1/2} = 3.06$ (E-1.64)] in the board energy range (1.6-3)eV, this means that r should equal to 2 in eqn. 2 in order to conform with the experimental results of Jackson etal [i.e q=0], which means that N(E') could be well approximated to a parabolic dependence on the state energy $E'[ieN(E')\alpha E'^{1/2}]$.

In order to check for that, we found the density of states convolution integral data announced by Jackson et al for GD a-Si:H in the energy range (0.6-5.9)eV most beneficial as we shall see below.

Results and Discussion

Fig.1 shows the main Jackson et al results [2] for ϵ_2 (E), J(E) (the density of states integral) and $R^2(E)$ in the photon energy range[~1.5-5.9]eV.

We have replotted Jackson et al J(E) data as $J^{1/2}(E)$ and $J^{1/3}(E)$ as a function of E in the wide range (1.6-3.7) eV as shown in fig. 2, which covers the high energy region of the optical absorption edge of a-Si:H in full.

We note and conclude the following from these plots.

(1) The function $J^{1/2}(E)$ extracted from experimental J(E) data highly correlates to a linear behaviour in the range (~1.78-3.25)eV a range which covers the high energy region of the absorption edge, and because J(E) does not depend on $R^2(E)$ and they depends only the density of state distributions of the valence and conduction bands (in contrast to $\alpha(E)$ or $\epsilon_2(E)$ which depend on both) therefore according to eq.2:

$$J(E)\alpha(E-E_a)^{2m+1}$$
 ----(3)

As r=2m+1=2 according to eq.2 then m should equal to $\frac{1}{2}$, which means that we can approximate the density of state distributions of the valence and conduction bands to a parabolic behaviour (i.e. $N(E)\alpha E^{1/2}$). We note from fig.2 that $J^{1/3}(E)$ data does not behave linearly with E at all excluding the narrow energy range (~1.78-2) eV.

- (2) The extrapolation of the straight line fit to J^{1/2}(E) to the energy axis (J=0) gives us Eo~1.68 eV, while the extrapolation of the short J^{1/3}(E) line is ~ 1.57 eV.
- (3) We conclude the following from the above important notions:

a) The density of states distributions of the valence and conduction bands edges of Jackson etal GD a-Si:H films (which are electronic grads films) can be approximated by a parabolic function i.e with m=1/2 in eq.2 (r=2m+1), this is in accordance with the original assumption of Tauc [5] that $N(E)\alpha E^{1/2}$ near the band edges of amorphous semiconductors similar to (at least) crystal semiconductors but for the special case of electronic grade GD a-Si:H films of least.

b) As Eo~1.68 eV for $J^{1/2}(E)$ plot, combined with experimental finding of Jackson et al that $R^2(E)$ is constant in the energy range interest and that $N(E)\alpha E^{1/2}$ near the band edges of valence and conduction bands of Jackson et al films, and noting that the $\epsilon_2^{1/2}(E)$ vs. E plot for Jackson et al films is linear in the energy range of interest (~1.6-3)eV with extrapolation to E-axis giving E_0 ~ 1.64 eV as given by Jackson et al in their paper which is close to the 1.68 eV for the $J^{1/2}(E)$ extrapolation. We conclude that the most proper theoretical model that should be adopted as the correct start towards a possible understanding of the high energy region of the absorption edge problem in a-Si:H, is the one that is due to Cody [1] who proposed $R^2(E)$ to be constant and $N(E)\alpha E^{1/2}$ near the band edges for a-Si:H films, excluding Tauc model which is not appropriate for GD a-Si:H films because he proposed that the momentum matrix P(E) to be constant and not the dipole matrix element in contradiction to the experimental finding of Jackson et al, and the Klazes et al [6] assumptions for a-Si:H films of $N(E)\alpha E^{1/2}$ and $P^2(E)$ is constant.

Stated in another and more practical way $E \in_2^{1/2}(\text{or }(\alpha/E)^{1/2})$ plot attributed to Cody [1] should be adopted for a-Si:H films and not $(E^2 \in_2)^{1/2}$ (or $(\alpha/E)^{1/2}$) attributed to Tauc [5] or $(E^2 \in_2)^{1/3}$ (or $(\alpha/E)^{1/3}$) attributed to Klazes et al [6] because the last two does not conform with the experimental findings of Jackson et al for GD a-Si:H at least . At the end , we think that our conclusions could be considered conclusive for the correct plot to adopt for \in_2 or α data of good energy gap problem in this material at least is automatically solved , and a correct physical meaning for E_{opt} defined as the extrapolation of $\in_2^{1/2}$ plot to the E-axis , should be searched for . Our attempts toward a possible solution of this problem will be published later .

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Figure Captions

- (1) Figure (1): Jackson et al results , for GD a-Si:H [2] (a) $\in_2 vs.E$ on a linear plot .
- (b) ∈₂ , J , and R² vs.E on a semi logarithmic plot .
 (2) Figure (2) : J^{1/2} and J^{1/3} vs.E plotted using Jackson et al J(E) data [2] in the energy range (1.6-3.7)eV .

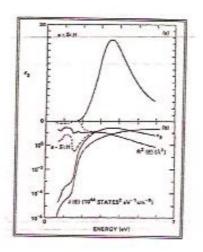


Figure (1): Jackson et al result, for GD a-Si:H [2] (a) σ_1 vs.E on a linear plot. (b) ε_2 , J, and R² vs.E on a semi logarithmic plot.

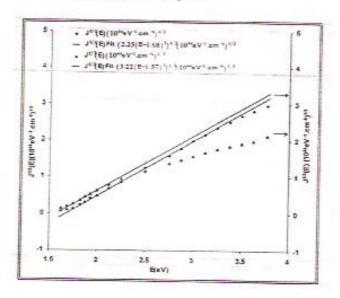


Figure (2) : $J^{1/2}$ and $J^{1/3}$ vs.E plotted using Jackson etal J(E) data [2] in the energy range (1.6-3.)eV .